



<p><b>Searched</b></p> 	<p>Application/Control No.</p> <p>10532979</p>	<p>Applicant(s)/Patent Under Reexamination</p> <p>HATORI ET AL.</p>
	<p>Examiner</p> <p>Roth, Laura K</p>	<p>Art Unit</p> <p>2852</p>

Class	SubClass	Date	Examiner
399	111	8/14/2006	LKR
399	113	8/14/2006	LKR
399	114	8/14/2006	LKR
399	115	8/14/2006	LKR
399	116	8/14/2006	LKR
399	119	8/14/2006	LKR
399	123	8/14/2006	LKR

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<b>Search Notes</b>  	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10532979	HATORI ET AL.
	Examiner Roth, Laura K	Art Unit 2852

Notes	Date	Examiner
399/111,113-116,119,123 (Text search only - see search history printout)	8/14/2006	LKR
399 class (text search only - see search history printout)	8/15/2006	LKR
EAST (US-PGPUB,USPAT,USOCR,FPRS,EPO,JPO,DERWENT,IBM_TD B) - text search only, see search history printout	8/16/2006	LKR
399 class (text search only, see search history printout)	8/16/2006	LKR
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